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Renesas Technology Corp. Customer Support Dept. April 1, 2003



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This d-c triggered multivibrator features output pulse width control by three method. The basic pulse time is programmed by selection of external resistance and capacitance values. Once triggered, the basic pulse width may be extended by retriggering the gated low-level-active (A) or high-level-active (B) inputs, or be reduced by use of the overriding clear. Fig. 1 illustrates pulse control by retriggering and early clear. This device is provided enough Schmitt hysteresis to ensure jitter-free triggering from the B input with transition rates as slow as 0.1 mV/ns.

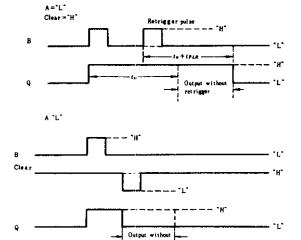
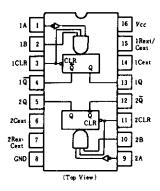
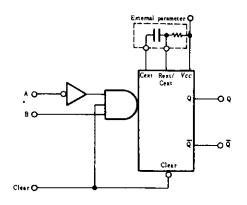


Fig.1 Typical Input/Output Pulses

■PIN ARRANGEMENT



■BLOCK DIAGRAM(½)



TRECOMMENDED OPERATING CONDITIONS

Iter	n		Symbol	min	typ	max	Unit
Y	A, B	.н.	Bw(in)	40		_	ns
Input pulse width		"L"		40		-	ns
WIGEN	CLR	"L"		40	_	_	ns
External timing resistance External capacitance		Rest	5		260	kΩ	
		Cest		Non res	triction	1	
Wiring capacitan Cext terminal	ce at Re	xt/			_	50	pF

IIIFUNCTION TABLE

	Inputs	Outputs		
CLEAR	A	Q	Q	
L	×	×	L	Н
×	Н	×	L	Н
×	×	L	L	Н
Н	L	ţ		7
Н	ļ	Н		7
1	L	Н		7

Notes) H; high level, L; low level, X; irrelevant

; transition from high to low level

t; transition from low to high level

∏; one high-level pulse

Ŭ; one low-level pulse

ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^{\circ}C$)

Item	Symbol	Test Conditions		min	typ*	max	Unit	
T	ViH			2.0		_	v	
Input voltage	VIL			-	_	0.8	V	
	Voн	$V_{CC} = 4.75 \text{V}, V_{IH} = 2 \text{V}, V_{IL} = 0.8 \text{V}$	', Ιοн= – 40 0μ A	2.7	_	_	V	
Output voltage	1,	$V_{CC} = 4.75 \text{V}, V_{IH} = 2 \text{V},$	$I_{OL} = 4 \mathrm{mA}$			0.4	v	
	Vol	$V_{IL}=0.8V$	IoL = 8mA	_	-	0.5	V	
	Іін	$V_{CC} = 5.25 \text{V}, V_{I} = 2.7 \text{V}$		-	_	20	μA	
Input current	ItL	$V_{CC} = 5.25 \text{V}, V_I = 0.4 \text{V}$. –	_	-0.4	mA		
	Iı	$V_{CC} = 5.25 \text{V}, V_I = 7 \text{V}$				0.1	mA	
Short-circuit output current	Ios	$V_{CC}=5.25V$		20	-	- 100	mΑ	
Supply current**	<i>Icc</i>	$V_{CC} = 5.25 \text{V}$. –	12	20	m A	
Input clamp voltage	VIK	$V_{CC} = 4.75 \text{V}, I_{IN} = -18 \text{mA}$			_	-1.5	V	

[•] *V_{CC}*=5V, *Ta*=25°C

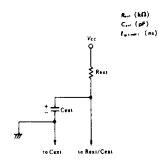
Note) To measure V_{OH} at Q, V_{OL} at \overline{Q} , or I_{OS} at Q, ground R_{ext}/C_{ext} , apply 2V to B and clear, and pulse A from 2V to 0V.

ESWITCHING CHARACTERISTICS ($V_{CC} = 5V$, $T_a = 25^{\circ}C$)

Item	Symbol	Inputs	Outputs	Test Conditions	min	typ	max	Unit		
	tplH		Q	$C_{est} = 0 pF$ $R_{est} = 5 k\Omega$ $C_L = 15 pF$ $R_L = 2 k\Omega$	_	23	33	ns		
	tphl.	А	Q			32	45			
	tPLH	В	Q		_	23	44			
Propagation delay time	tphL .		Q			34	56			
	<i>t</i> ₽#L	CI D	Q		_	20	27			
	t PLH	CLR	ZLK Q	$- RL = 2k\Omega$		28	45	1		
	twiout)min		.+		*	-	_	116	200	
Output pulse width	l _{selout)}	A, B	Q	$C_{ext} = 1,000 \text{pF}, R_{ext} = 10 \text{k}\Omega$ $C_L = 15 \text{pF}, R_L = 2 \text{k}\Omega$	4	4.5	5	μs		

ETYPICAL APPLICATION DATA FOR HD74LS123

For pulse widths when Cext < 1000 pF, See Fig. 3. The output pulse is primarily a function of the external capacitor and resistor. For $C_{ext} > 1000 pF$, the output pulse width (tw) is defined as: tw(out) = K - Rext - Cext; See Fig. 4



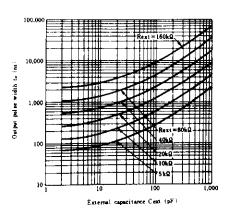


Fig.3 Typical Output Pulse Width (Cext≤1000pF)

Fig.2 Timing Component Connections

^{**} With all outputs open and 4.5V applied to all data and clear inputs, I_{CC} is measured after a momentary ground, then 4.5V, is applied clock.

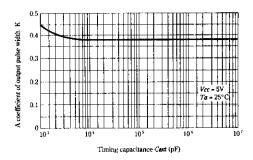
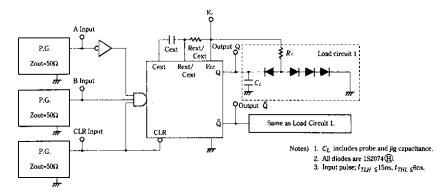


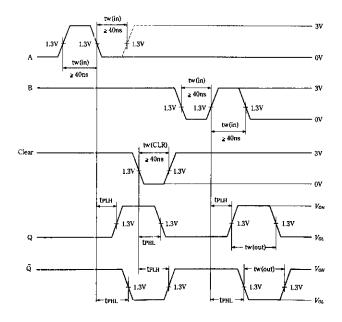
Fig.4 Cext vs K (Cext > 1000pF)

TESTING METHOD

1) Test Circuit

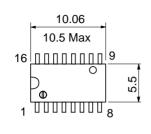


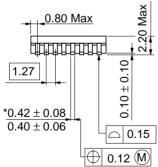
Waveform

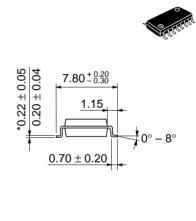


Unit: mm 19.20 20.00 Max 16 7.40 Max 6.30 1.3 1.11 Max 7.62 5.06 Max 2.54 Min 0.51 Min $0.25^{+0.13}_{-0.05}$ 0.48 ± 0.10 2.54 ± 0.25 $0^{\circ} - 15^{\circ}$ Hitachi Code DP-16 **JEDEC** Conforms EIAJ Conforms Weight (reference value) 1.07 g

Unit: mm



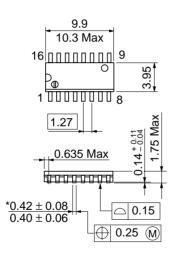


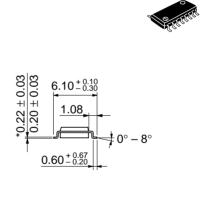


*Dimension including the plating thickness
Base material dimension

Hitachi Code	FP-16DA
JEDEC	_
EIAJ	Conforms
Weight (reference value)	0.24 g

Unit: mm





*Dimension including the plating thickness
Base material dimension

Hitachi Code	FP-16DN
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.15 g

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